

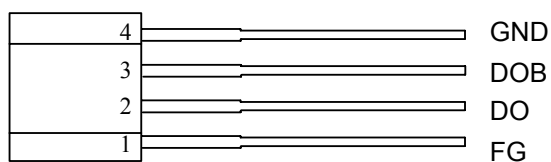
**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Pin Configuration**Z4 Package  
(TO-94)

Figure 2. Pin Configuration of AH211 (Front View)

**Pin Description**

Pin Number	Pin Name	Function
1	FG	Frequency Generation
2	DO	Output 1
3	DOB	Output 2
4	GND	Ground

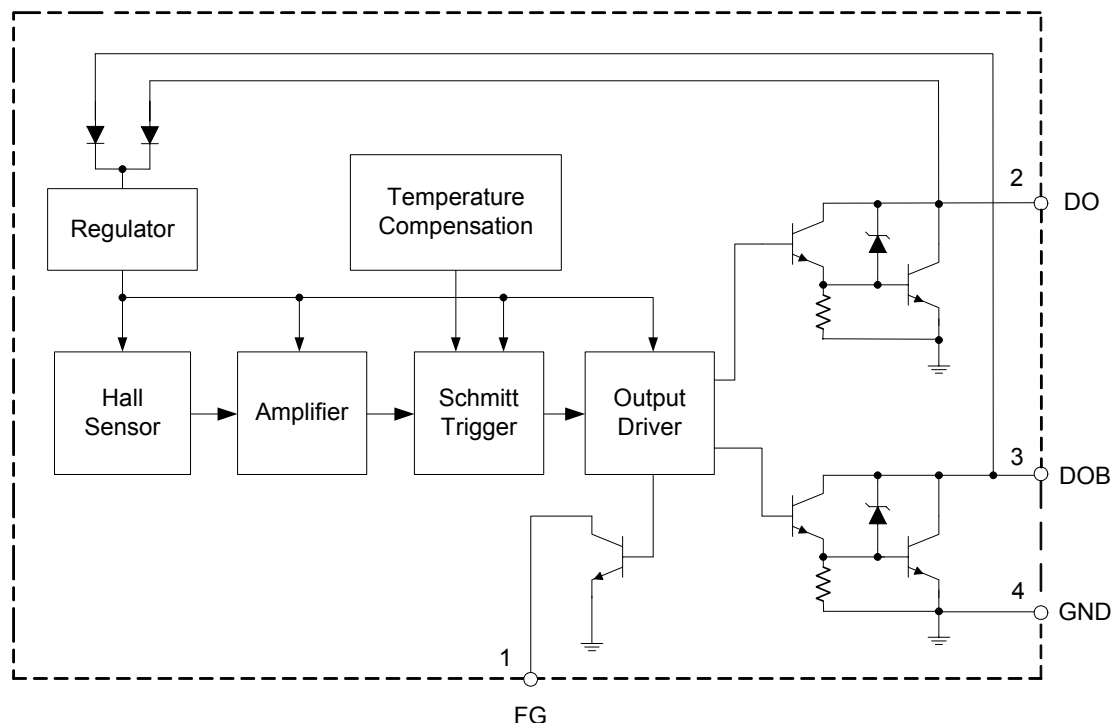
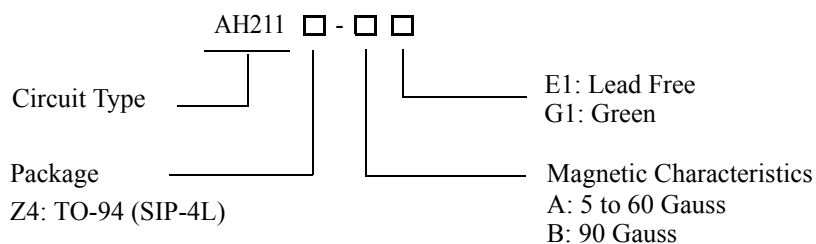
**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Functional Block Diagram**

Figure 3. Functional Block Diagram of AH211

**Ordering Information**

Package	Temperature Range	Part Number		Marking ID		Packing Type
		Lead Free	Green	Lead Free	Green	
TO-94	-20 to 85 °C	AH211Z4-AE1	AH211Z4-AG1	AH211	AH211Z4-G1	Bulk
		AH211Z4-BE1	AH211Z4-BG1	AH211	AH211Z4-G1	Bulk

BCD Semiconductor's Pb-free products, as designated with "E1" suffix in the part number, are RoHS compliant. Products with "G1" suffix are available in green package.

**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Absolute Maximum Ratings (Note 1)**(T<sub>A</sub>=25°C)

Parameter		Symbol	Value	Unit
Supply Voltage		V <sub>CC</sub>	20	V
Magnetic Flux Density		B	Unlimited	Gauss
Output Current	Continuous	I <sub>O</sub>	400	mA
	Hold		600	mA
	Peak (Start up)		800	mA
FG Voltage		V <sub>FG</sub>	30	V
FG Current		I <sub>FG</sub>	20	mA
Power Dissipation		P <sub>D</sub>	550	mW
Thermal Resistance	Die to Atmosphere	θ <sub>JA</sub>	227	°C/W
	Die to Package Case	θ <sub>JC</sub>	49	°C/W
Storage Temperature		T <sub>STG</sub>	-50 to 150	°C
ESD (Machine Model)			600	V
ESD (Human Body Model)			6000	V

Note 1: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. "Absolute Maximum Ratings" for extended period may affect device reliability.

**Recommended Operating Conditions**(T<sub>A</sub>=25°C)

Parameter	Symbol	Min	Max	Unit
Supply Voltage	V <sub>CC</sub>	3.5	16	V
Ambient Temperature	T <sub>A</sub>	-20	85	°C



## TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT

AH211

### Electrical Characteristics

(T<sub>A</sub>=25°C, V<sub>CC</sub>=14V, unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Output Saturation Voltage	V <sub>SAT</sub>	B>150Gauss, V <sub>CC</sub> =3.5V, V <sub>DOB</sub> =V <sub>CC</sub> , I <sub>DO</sub> =100mA (or B<-150Gauss, V <sub>CC</sub> =3.5V, V <sub>DO</sub> =V <sub>CC</sub> , I <sub>DOB</sub> =100mA)		1.1		V
		B>150Gauss, V <sub>DOB</sub> =V <sub>CC</sub> , I <sub>DO</sub> =400mA (or B<-150Gauss, V <sub>DO</sub> =V <sub>CC</sub> , I <sub>DOB</sub> =400mA)		1.05	1.3	V
FG Saturation Voltage	V <sub>SATF</sub>	B<-150Gauss, V <sub>DO</sub> =V <sub>CC</sub> , I <sub>FG</sub> =20mA		0.35	0.6	V
FG Leakage Current	I <sub>OLF</sub>	B>150Gauss, V <sub>DOB</sub> =V <sub>CC</sub> , V <sub>FG</sub> =16V		0.1	10	μA
Supply Current	I <sub>CC</sub>	B>150Gauss, V <sub>DOB</sub> =V <sub>CC</sub> , (or B<-150Gauss, V <sub>DO</sub> =V <sub>CC</sub> )		4	8	mA
Output Rise Time	t <sub>r</sub>	R <sub>L</sub> =1kΩ, C <sub>L</sub> =10pF		3.0	10	μs
Output Fall Time	t <sub>f</sub>	R <sub>L</sub> =1kΩ, C <sub>L</sub> =10pF		0.3	1.0	μs
Switch Time Differential	Δt	R <sub>L</sub> =1kΩ, C <sub>L</sub> =10pF		3.0	10	μs
Output Zener Breakdown Voltage	V <sub>Z</sub>			31		V

### Magnetic Characteristics

(T<sub>A</sub>=25°C)

Parameter	Symbol	Grade	Min	Typ	Max	Unit
Operating Point	B <sub>OP</sub>	A	5	30	60	Gauss
		B			90	Gauss
Releasing Point	B <sub>RP</sub>	A	-60	-30	-5	Gauss
		B	-90			Gauss
Hysteresis	B <sub>HYS</sub>			60		Gauss

# TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT

AH211

## Magnetic Characteristics (Continued)

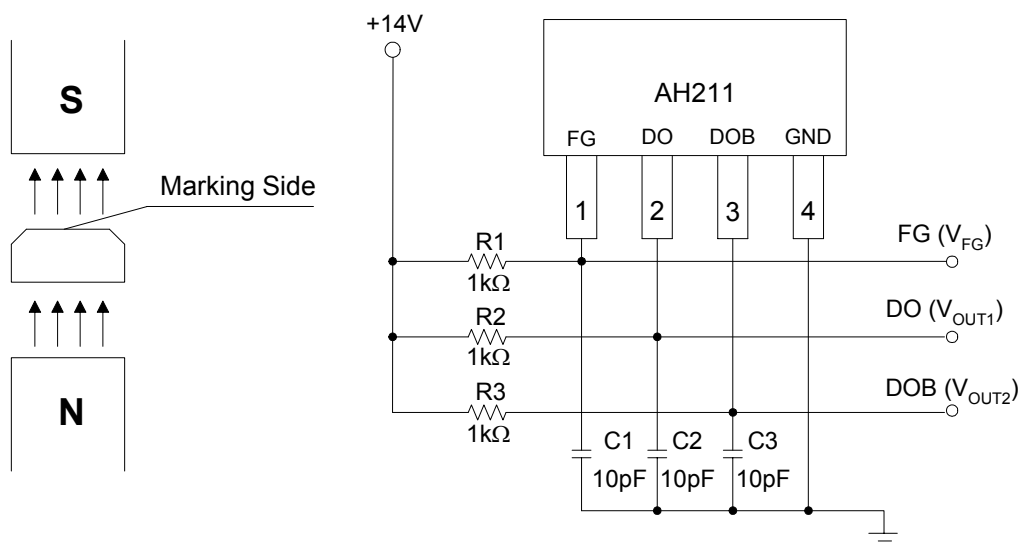
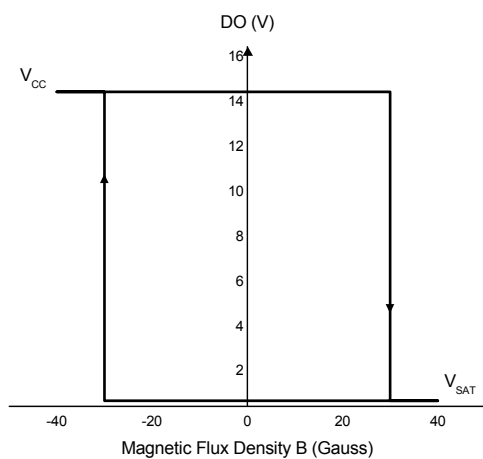
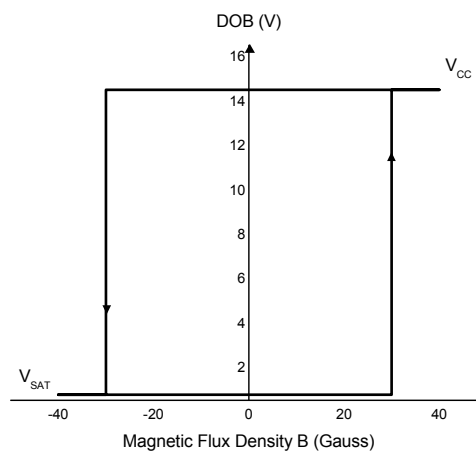
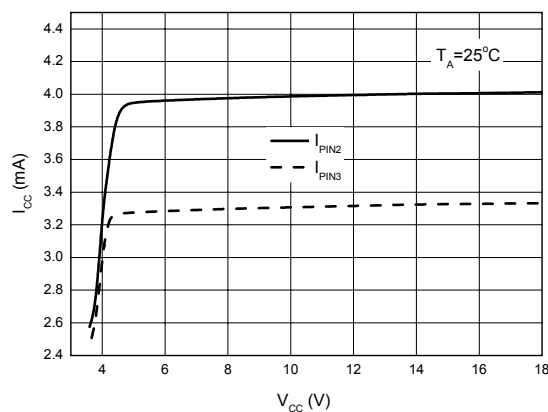
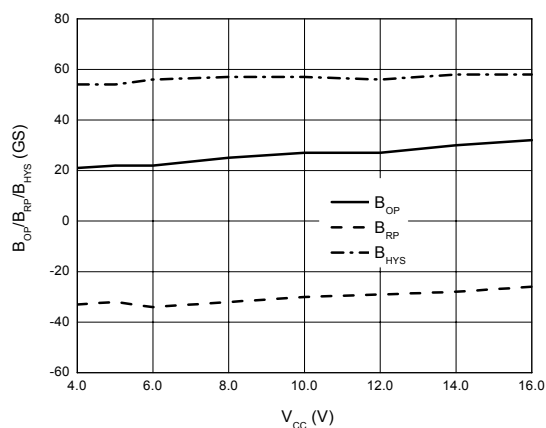
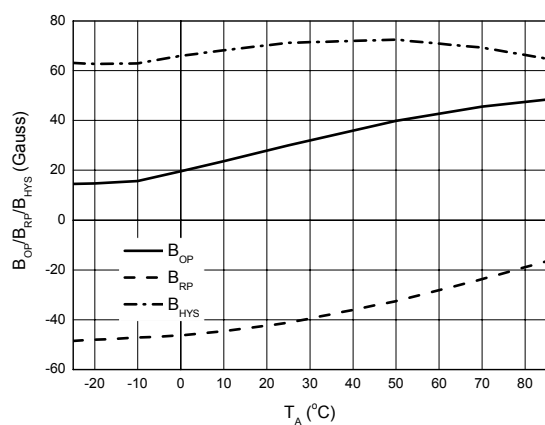
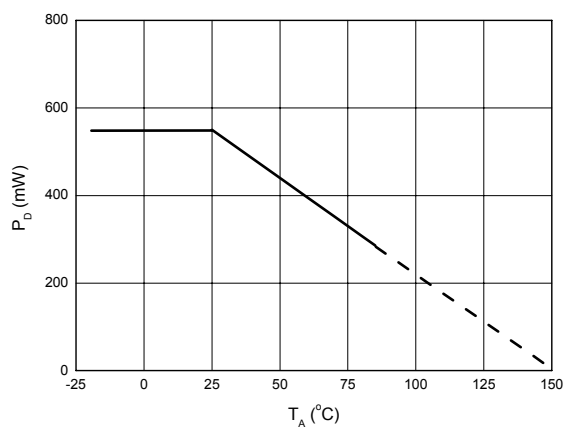


Figure 4. Basic Test Circuit


Figure 5.  $V_{DO}$  vs. Magnetic Flux Density

Figure 6.  $V_{DOB}$  vs. Magnetic Flux Density

**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Typical Performance Characteristics**Figure 7.  $I_{CC}$  vs.  $V_{CC}$ Figure 8.  $B_{OP}/B_{RP}/B_{HYS}$  vs.  $V_{CC}$ Figure 9.  $B_{OP}/B_{RP}/B_{HYS}$  vs. Ambient TemperatureFigure 10.  $P_D$  vs. Ambient Temperature

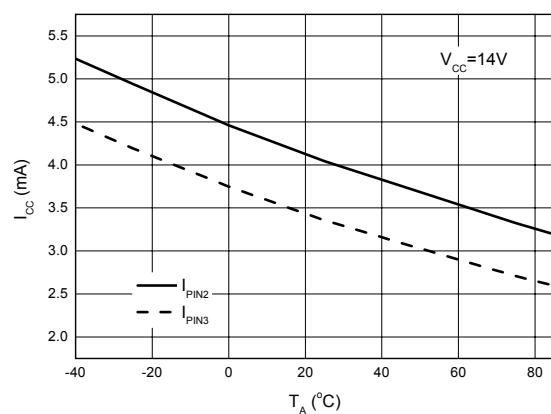
**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Typical Performance Characteristics (Continued)**

Figure 11. Supply Current vs. Ambient Temperature

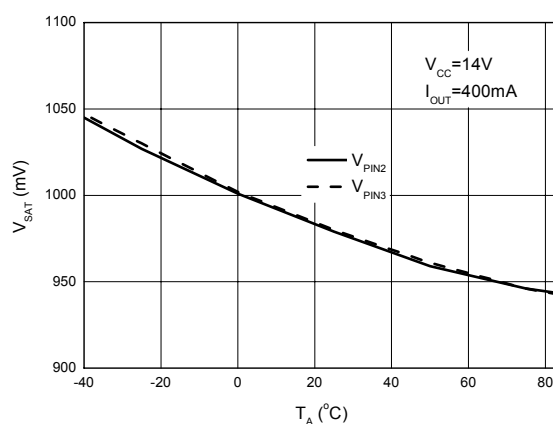
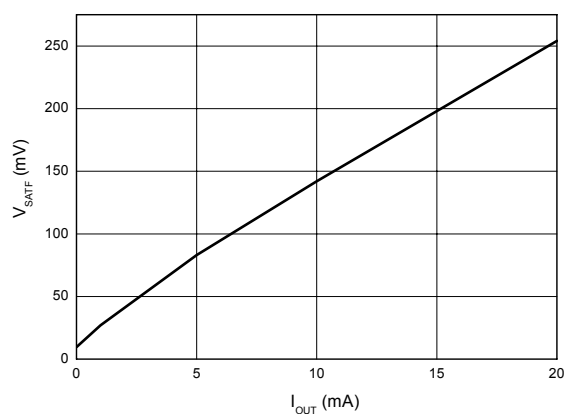
Figure 12.  $V_{SAT}$  vs. Ambient Temperature

Figure 13. FG Saturation Voltage vs. Output Current

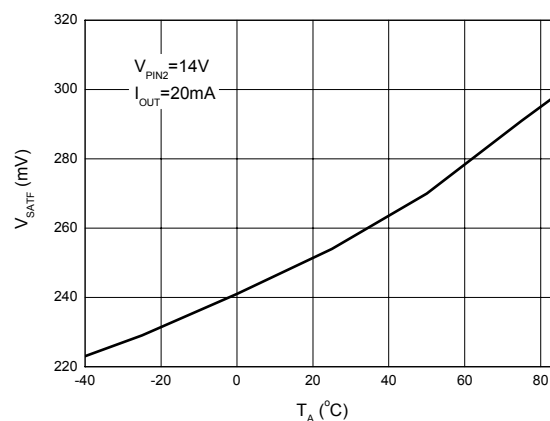


Figure 14. FG Saturation Voltage vs. Ambient Temperature

**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Application Information**

Figure 15 is the typical application circuit for AH211. Usually, there are three wires for fan connection: the red is input of power supply; the yellow is the output of FG; the black is the ground. R1 is an external pull-up resistor for the use of measuring FG signal from fan. The value of R1 could be decided by the transistor saturation voltage ( $V_{ON}$ ), sink current ( $I_{FG}$ ), and pull-up voltage ( $V_{DD}$ ). The calculation formula is:

$$R1 = (V_{DD} - V_{ON}) / I_{FG}$$

For example:

$V_{DD} = 5V$  for TTL level.

If saturation voltage is 0.6V (IC specification)  
 $I_{FG} = 20mA$  ( $\leq 20mA$ ), then  $R1 = 220\Omega$ ;

If saturation voltage is 0.1V,  $I_{FG} = 1mA$  ( $\leq 20mA$ ), the value of  $R1 = 4.9k\Omega$

According AH211's specification, if  $V_{DD} = 5V$ , R1 must be larger than  $220\Omega$

D1 is the reverse protection diode. If the red and black wires reversely connected, the current will flow from the ground via IC and coils L1 and L2 to power supply. Under such circumstances, the IC and coils are easy to be burned out. Therefore, the reverse protection diode D1 is necessary. However, D1 will also cause an extra voltage drop on the supply voltage.

C1 is a capacitor to reduce the ripple noise caused by the transient of the output stages. The amplitude of the ripple noise depends on the coil impedance and its characteristics.

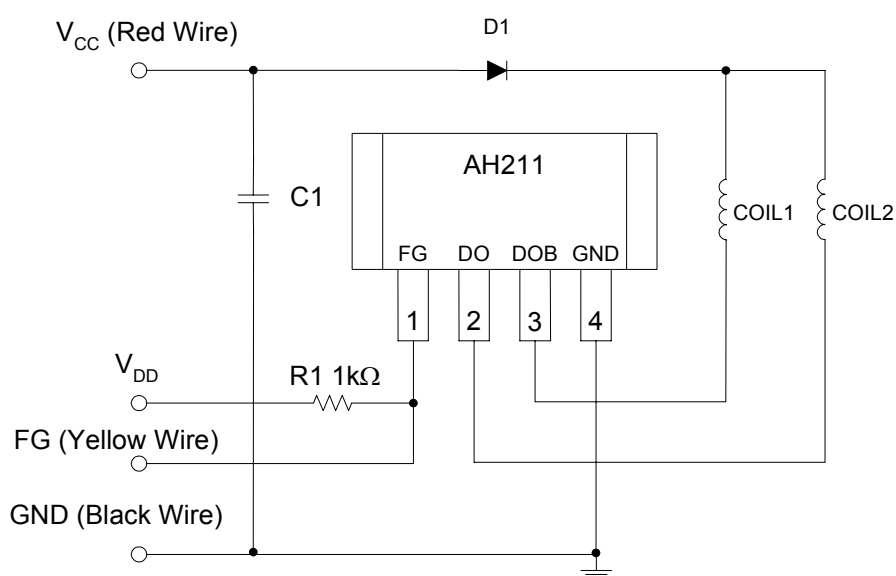
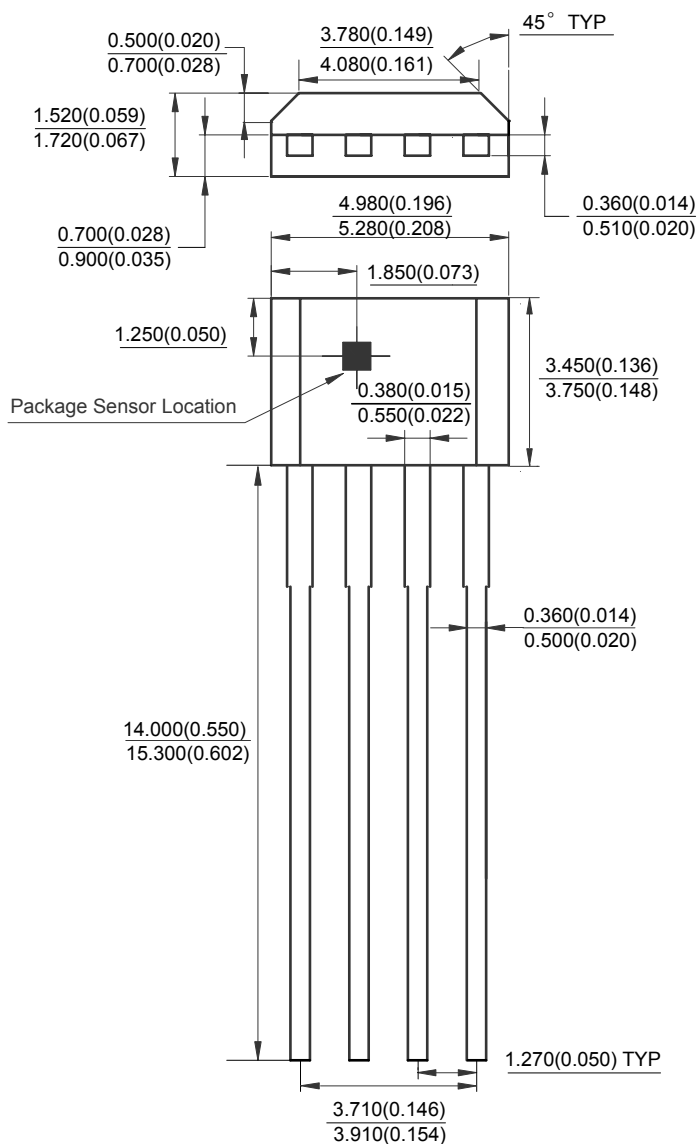


Figure 15. AH211 Typical Application Circuit



**TWO PHASE HALL EFFECT LATCH WITH FG OUTPUT****AH211****Mechanical Dimensions****TO-94****Unit: mm(inch)**



## BCD Semiconductor Manufacturing Limited

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